

# IGBT Chip in NPT-technology

#### **FEATURES:**

- 600V NPT technology 100µm chip
- positive temperature coefficient
- easy paralleling
- integrated gate resistor

## This chip is used for:

IGBT Modules

# G

## Applications:

drives

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code
SIGC121T60NR2C	600V	150A	11 x 11 mm <sup>2</sup>	sawn on foil	Q67041-A4684- A001

#### **MECHANICAL PARAMETER:**

Raster size	11 x 11	mm <sup>2</sup>		
Area total / active	121 / 102.5	1		
Emitter pad size	8 x 6.2 x 2.55			
Gate pad size	1.51 x 0.8			
Thickness	100	μm		
Wafer size	150	mm		
Flat position	90	grd		
Max.possible chips per wafer	106			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1200 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	Al, <500μm			
Reject Ink Dot Size	∅ 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	600	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	450	Α
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

# STATIC CHARACTERISTICS (tested on chip), $T_i$ =25 °C, unless otherwise specified:

Parameter	Symbol Conditions		Value			Unit
- urumeter	Cymbol	Conditions	min.	typ.	max.	J
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0 $V$ , $I_{C}$ =4 $mA$	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =150A	1.7	2	2.5	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	$I_C=3mA$ , $V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =600V, V <sub>GE</sub> =0V			10.2	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V, V <sub>GE</sub> =20V			480	nA
Integrated gate resistor	R <sub>Gint</sub>			5	7	Ω

## **ELECTRICAL CHARACTERISTICS** (tested at component):

Parameter	Symbol Conditions	Value			Unit	
raiailletei	Syllibol	Conditions	min.	typ.	max.	Joilit
Input capacitance	Ciss	V <sub>CE</sub> =25V	-	6500		pF
Output capacitance	Coss	V <sub>GE</sub> =0V	-	tbd		
Reverse transfer capacitance	Crss	f=1MHz	-	600		

# SWITCHING CHARACTERISTICS (tested at component), Inductive Load

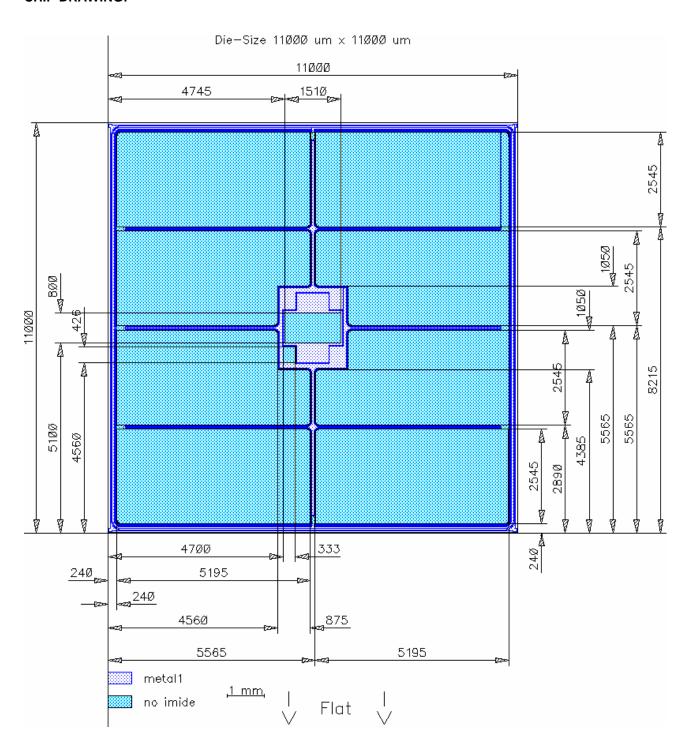
Parameter	Symbol	Symbol Conditions 1)		Value		
- arameter	Syllibol	Conditions	min.	typ.	max.	Unit
Turn-on delay time	$t_{d(on)}$	T <sub>j</sub> =125°C	-	125		ns
Rise time	$t_{r}$	V <sub>CC</sub> =300V	-	30		
Turn-off delay time	$t_{d(off)}$	I <sub>C</sub> =150 A, V <sub>GE</sub> =-15/15V	-	225		
Fall time	$t_{f}$	$R_{\rm G}$ =1.5 $\Omega$	-	35		

<sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.

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## **CHIP DRAWING:**





#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet	BSM 150 GD 60 DLC			
DESCRIPTION:				
AQL 0,65 for visual inspection according to failure catalog				
Electrostatic Discharge Sensitive Device according to MIL-STD 883				
Test-Normen Villach/Prüffeld				

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